

TEST REPORT

Report No.: BCTC2408508635-2E

Applicant: Radxa Computer (Shenzhen) Co.,Ltd.

Product Name: Radxa CM3I

Test Model: Radxa CM3I D2E8J1W13

Tested Date: 2024-08-27 to 2024-09-04

Issued Date: 2024-09-18

Shenzhen BCTC Testing Co., Ltd.



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Product Name: Radxa CM3I

Trademark:

Radxa CM3I D2E8J1W13

Radxa CM3I D2E0J1W13, Radxa CM3I D2E16J1W13, Radxa CM3I D4E0J1W13, Radxa CM3I D4E8J1W13,

Model/Type reference: Radxa CM3I D4E16J1W13, Radxa CM3I D4E32J1W13,

Radxa CM3I D8E0J1W13, Radxa CM3I D8E32J1W13,

Radxa CM3I D8E64J1W13

Prepared For: Radxa Computer (Shenzhen) Co.,Ltd.

Address: 1602, Smart Valley, tiezai Road, Gongle community, Xixiang, Baoan, Shenzhen

Manufacturer: Radxa Computer (Shenzhen) Co.,Ltd.

Address: 1602, Smart Valley, tiezai Road, Gongle community, Xixiang, Baoan, Shenzhen

Prepared By: Shenzhen BCTC Testing Co., Ltd.

1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Address:

Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China

Sample Received Date: 2024-08-27

Sample tested Date: 2024-08-27 to 2024-09-04

Issue Date: 2024-09-18

Report No .: BCTC2408508635-2E

ETSI EN 301 489-1 V2.2.3 (2019-11) Test Standards: ETSI EN 301 489-3 V2.3.2 (2023-01)

ETSI EN 301 489-17 V3.2.4 (2020-09)

Test Results: **PASS**

Remark: This is RED EMC test report

Tested by:

Brave Zeng/ Project Handler

Approved by:

Zero Zhou/Reviewer

The test report is effective only with both signature and specialized stamp. This result(s) shown in this report refer only to the sample(s) tested. Without written approval of Shenzhen BCTC Testing Co., Ltd, this report can't be reproduced except in full. The tested sample(s) and the sample information are provided by the client.

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(Note: N/A Means Not Applicable)

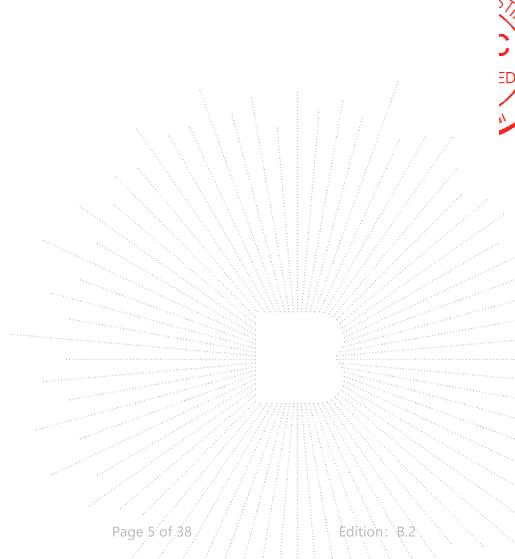






1. Version

Report No.	Issue Date	Description	Approved
BCTC2408508635-2E	2024-09-18	Original	Valid



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2. Test Summary

The Product has been tested according to the following specifications:

EMISSION						
Standard	Test Item	Test result				
EN 301 489-1	Conducted emissions from the AC mains power ports	Pass				
EN 301 489-1	Asymmetric mode conducted emissions	Pass				
EN 301 489-1	Conducted differential voltage emissions	N/A²				
EN 301 489-1	Radiated emissions	Pass				
EN 301 489-1	Harmonic current emission(H)	N/A ³				
EN 301 489-1	Voltage fluctuations & flicker(F)	N/A ⁴				

IMMUNITY					
Standard	Test Item	Test result			
EN 301 489-1	Electrostatic discharge (ESD)	Pass			
EN 301 489-1	Continuous RF electromagnetic field disturbances(RS)	Pass			
EN 301 489-1	Electrical fast transients/burst (EFT)	N/A ⁴			
EN 301 489-1	Surges	N/A ⁴			
EN 301 489-1	Radio frequency, common mode	N/A ⁴			
EN 301 489-1	Voltage dips and interruptions (DIPS)	N/A ⁴			

Remark:

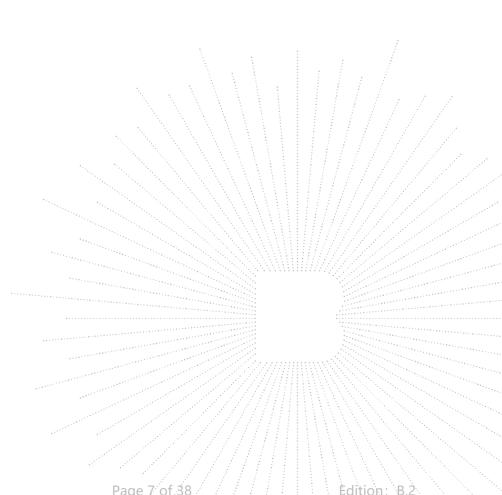
- 1. Applicable to ports listed above and intended to connect to cables longer than 3 m.
- 2. The Product has no antenna port.
- 3. The Product belongs to Class A, and its power is less than 75W, so it deems to fulfil this standard without testing.
- 4. The EUT is powered by the DC only, the test item is not applicable.



3. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the Product as specified in CISPR 16-4-2. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Test item	Value (dB)
Conducted Emission (150kHz-30MHz)	3.10
Asymmetric mode conducted emissions (150kHz-30MHz)	3.90(cat 3) 4.30(cat 5) 4.80(cat 6)
Radiated Emission(30MHz~200MHz)	4.60
Radiated Emission(200MHz~1GHz)	5.20
Radiated Emission(1GHz~6GHz)	5.20



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4. Product Information And Test Setup

4.1 Product Information

Radxa CM3I D2E8J1W13

Radxa CM3I D2E0J1W13, Radxa CM3I D2E16J1W13, Radxa CM3I D4E0J1W13, Radxa CM3I D4E8J1W13,

Model/Type reference: Radxa CM3I D4E031W13, Radxa CM3I D4E32J1W13, Radxa CM3I D4E32J1W13,

Radxa CM3I D8E0J1W13, Radxa CM3I D8E32J1W13,

Radxa CM3I D8E64J1W13

Model differences:

All models are the same circuit and RF module, only the model name and memory

size are different.

Bluetooth version: 5.0
Hardware Version: N/A
Software Version: N/A

Bluetooth(BDR+EDR)+ Bluetooth(BLE): 2402-2480MHz WIFI(2.4GHz): IEEE 802.11b/g/n HT20: 2412-2472MHz WIFI(5.1GHz): IEEE 802.11a/n/ac HT20:5180MHz-5240MHz IEEE 802.11n/ac HT40:5190MHz-5230MHz

Operation Frequency: IEEE 802.11ac HT80:5210MHz

WIFI(5.8GHz): IEEE 802.11a/n/ac HT20:5745MHz-5825MHz

IEEE 802.11n/ac HT40:5755 MHz-5795MHz

IEEE 802.11ac HT80:5775MHz

Bluetooth(BDR+EDR): 0.3 dBm Bluetooth(BLE): 5.52 dBm

Max. RF output power: WIFI(2.4GHz): 12.33 dBm

WIFI(5.1GHz): 10.87 dBm WIFI(5.8GHz): 9.56 dBm

Bluetooth(BDR+EDR): GFSK, π/4DQPSK, 8DPSK

Type of Modulation: Bluetooth(BLE):GFSK

WIFI(2.4GHz): DSSS, OFDM

WIFI(5GHz): OFDM-BPSK, QPSK, 16QAM, 64QAM, 256QAM

Antenna installation: FPC antenna

Bluetooth(BDR+EDR)+ Bluetooth(BLE)+ WIFI(2.4GHz): 1.65 dBi

WIFI(5.1GHz)+ WIFI(5.8GHz): 1.41 dBi

Remark:

Antenna Gain: The antenna gain of the product comes from the antenna report provided by the

customer, and the test data is affected by the customer information.

The antenna gain of the product is provided by the customer, and the test data

is affected by the customer information.

Ratings: DC 12V from adapter.

Cable of Product

No.	Cable Type	Quantity	Provider	Length (m)	Shielded	Note
1			Applicant		No	With a ferrite ring in mid Detachable
2			встс		No	

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4.2 Test Setup Configuration

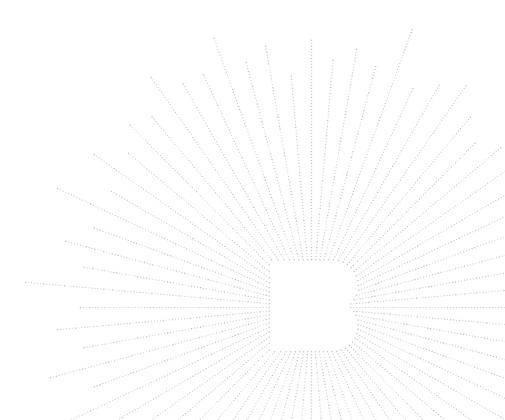
See test photographs attached in EUT TEST SETUP PHOTOGRAPHS for the actual connections between Product and support equipment.

4.3 Support Equipment

No.	Device Type	Brand	Model	Series No.	Note
1.	Adapter				
2.	Mouse	Logitech	M-U0026		
3.	U disk	SanDisk	32G		
4.	Router	HUAWEI	WS318		
5.	HDMI Cable	Belkin	HDMI2.0		
6.	Display	ChangHong	55DBK		
7.	TF card	SanDisk	128G		
8.	keyboard	Logitech	1641MG01DLZ8		

Notes:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.



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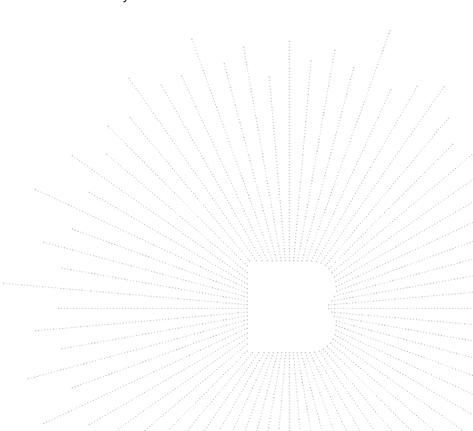


4.4 Test Mode

Test item	Test Mode	Test Voltage
Conducted emissions from the AC mains power ports (150KHz-30MHz) Class B	Mode 1	AC 230V/50Hz
Asymmetric mode conducted emissions(150KHz-30MHz) Class B	Mode 1	AC 230V/50Hz
Radiated emissions(30MHz-6GHz) Class B	Mode 1	AC 230V/50Hz
Electrostatic discharge (ESD) HCP & VCP: ±4Kv, ±2Kv Air Discharge: ±8Kv, ±4Kv, ±2Kv Contact Discharge: ±4Kv, ±2Kv 10 times each point/	Mode 1	AC 230V/50Hz
Continuous RF electromagnetic field disturbances(RS) 80MHz-1000MHz, 1800MHz, 2600MHz,3500MHz,5000MHz 3V/m,80% AM Front, Rear, Left, Right, H/V	Mode 1	AC 230V/50Hz

Remark:

Mode 1: BT+WIFI+HDMI+RJ45+Mouse+USB+TF+keyboard



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5. Test Facility And Test Instrument Used

5.1 Test Facility

All measurement facilities used to collect the measurement data are located at Shenzhen BCTC Testing Co., Ltd. Address: 1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China. The site and apparatus are constructed in conformance with the requirements of ANSI C63.4 and CISPR 16-1-1 other equivalent standards.

5.2 Test Instrument Used

Conducted Emissions Test								
Equipment	Equipment Manufacturer Model# Serial# Last Cal. Next Cal.							
Receiver	R&S	ESR3	102075	May 16, 2024	May 15, 2025			
LISN	R&S	ENV216	101375	May 16, 2024	May 15, 2025			
ISN	HPX	ISN T800	S1509001	May 16, 2024	May 15, 2025			
Software	Frad	EZ-EMC	EMC-CON 3A1	\	\			
Pulse limiter	Schwarzbeck	VTSD 9561-F	01323	May 16, 2024	May 15, 2025			

Radiated Emissions Test (966 Chamber#01)							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
966 chamber	ChengYu	966 Room	966	May 15, 2023	May 14, 2026		
Receiver	R&S	ESRP	101154	May 16, 2024	May 15, 2025		
Receiver	R&S	ESR3	102075	May 16, 2024	May 15, 2025		
Amplifier	SKET	LAPA_01G18 G-45dB	SK2021040901	May 16, 2024	May 15, 2025		
Amplifier	Schwarzbeck	BBV9744	9744-0037	May 16, 2024	May 15, 2025		
TRILOG Broadband Antenna	schwarzbeck	VULB9163	942	May 21, 2024	May 20, 2025		
Horn Antenna	schwarzbeck	BBHA9120D	1541	May 21, 2024	May 20, 2025		
Software	Frad	EZ-EMC	FA-03A2 RE		///X///		

Electrostatic Discharge Test							
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.		
Electrostatic Discharge Simulator	3C TEST	EDS 30T	ES031000123 059	Mar. 13, 2024	Mar. 12, 2025		

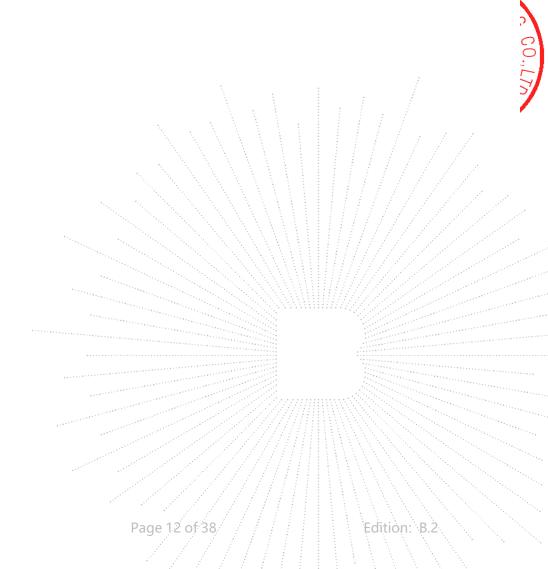
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	Continuous RF Electromagnetic Field Disturbances Test									
Equipment	Manufacturer	Model#	Serial#	Last Cal.	Next Cal.					
Power meter	Keysight	E4419	A00065	May 16, 2024	May 15, 2025					
Power sensor	Keysight	E9300A	US39211659	May 16, 2024	May 15, 2025					
Power sensor	Keysight	E9300A	US39211305	May 16, 2024	May 15, 2025					
Amplifier	SKET	HAP_801000 -250W	21201805013	May 16, 2024	May 15, 2025					
Amplifier	SKET	HAP_0103-7 5W	21201805014	May 16, 2024	May 15, 2025					
Amplifier	SKET	HAP_0306-5 0W	21201805015	May 16, 2024	May 15, 2025					
Stacked double LogPer. Antenna	Schwarzbeck	STLP 9129	00077	\	١					
Field Probe	Narda	EP-601	611WX80256	May 25, 2024	May 24, 2025					
Signal Generator	Agilent	N5181A	MY50143748	May 16, 2024	May 15, 2025					
Software	SKET	EMC-S	1.2.0.18	\	\					

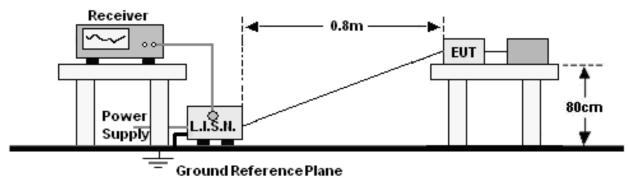




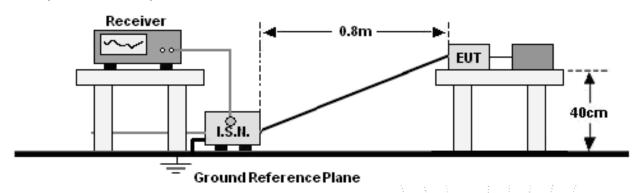
6. Conducted Emissions

6.1 Block Diagram Of Test Setup

For mains ports:



For asymmetric mode ports:



6.2 Limit

Limits for Conducted emissions at the mains ports of Class B MME

Frequency range	Limits dB(μV)				
(MHz)	Quasi-peak	Average			
0,15 to 0,50	66 to 56*	56 to 46*			
0,50 to 5	56	46			
5 to 30	60	50			

Notes: 1. *Decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies.

Limits for asymmetric mode conducted emissions of Class B MME

Frequency range	Voltage Lir	nits dB(μV)	Current Limits dB(µA)
(MHz)	Quasi-peak	Average	Quasi-peak Average
0,15 to 0,50	84-74	74-64	40-30 30-20
0,50 to 30	74	64	30 / 20

Notes: *Decreasing linearly with logarithm of frequency.

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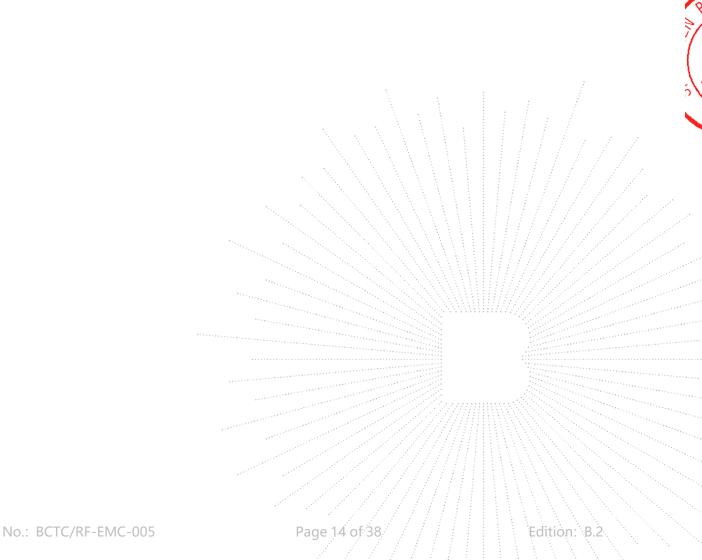
6.3 Test Procedure

For mains ports:

- a. The Product was placed on a nonconductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the main through Line Impedance Stability Network (L.I.S.N).
- b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.

For asymmetric mode ports:

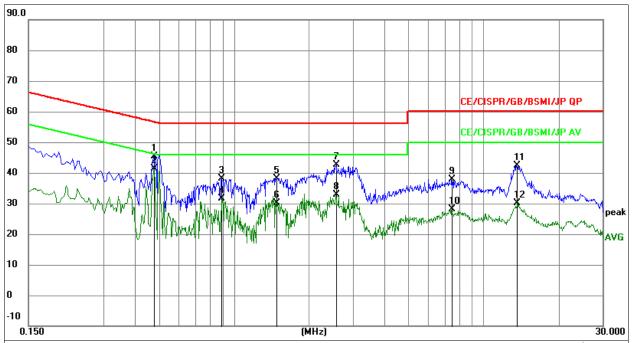
- a. The Product was placed on a non-conductive table 0.8 m above the horizontal ground reference plane, and 0.4 m from the vertical ground reference plane, and connected to the associated port through current probe.
- b. The RBW of the receiver was set at 9 kHz in 150 kHz ~ 30MHz with Peak and AVG detector in Max Hold mode. Run the receiver's pre-scan to record the maximum disturbance generated from Product in all power lines in the full band.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP and AVG values and record.





6.4 Test Result

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Phase :	L
Test Mode:	Mode 1	Remark:	N/A



Remark:

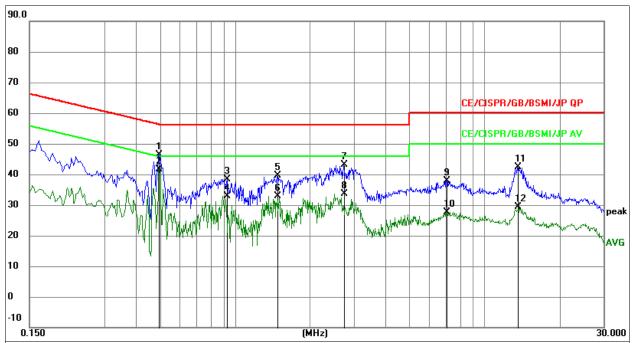
- All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.
- Measurement=Reading Level+ Correct Factor
 Over= Measurement-Limit

4. Over	= ivieasur	ement-Limit						<u> </u>
No	. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz		dB	dBu∨	dBuV	dB	Detector
1		0.4785	25.27	20.08	45.35	56.37	-11.02	QP
2	*	0.4785	21.23	20.08	41.31	46.37	-5.06	AVG
3		0.8925	18.13	20.09	38.22	56.00	-17.78	QP
4		0.8925	11.46	20.09	31.55	46.00	-14.45	AVG
5		1.4865	18.14	20.09	38.23	56.00	-17.77	QP
6		1.4865	10.09	20.09	30.18	46.00	-15.82	AVG
7		2.5755	22.58	20.11	42.69	56.00	-13.31	QP
8		2.5755	12.85	20.11	32.96	46.00	-13.04	AVG
9		7.4805	17.61	20.16	37.77	60.00	-22.23	QP
10		7.4805	7.92	20.16	28.08	50.00	-21.92	AVG
11		13.5825	22.18	20.27	42.45	60.00	-17.55	QP
12		13.5825	9.82	20.27	30.09	50.00	-19.91	AVG

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Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Phase :	Ν
Test Mode:	Mode 1	Remark:	N/A



Remark:

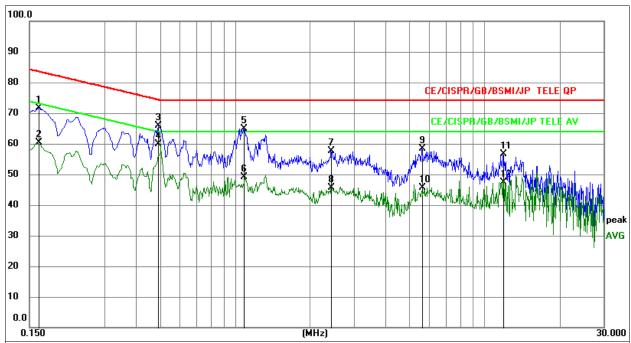
- All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.
 Measurement=Reading Level+ Correct Factor

- 4. Over= Measurement-Limit

No. Mk. Freq. Level Factor ment Limit Over MHz dB dBuV dBuV dB dB 1 0.4965 26.37 20.08 46.45 56.06 -9.61 2 * 0.4965 21.55 20.08 41.63 46.06 -4.43 3 0.9284 18.40 20.09 38.49 56.00 -17.51 4 0.9284 12.72 20.09 32.81 46.00 -13.19 5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 7.57 20.16 27.73 50.00 -22.27 10 7.0620 7.57 20.16			CITICITE LITTIE	- ·					
1 0.4965 26.37 20.08 46.45 56.06 -9.61 2 * 0.4965 21.55 20.08 41.63 46.06 -4.43 3 0.9284 18.40 20.09 38.49 56.00 -17.51 4 0.9284 12.72 20.09 32.81 46.00 -13.19 5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
2 * 0.4965 21.55 20.08 41.63 46.06 -4.43 3 0.9284 18.40 20.09 38.49 56.00 -17.51 4 0.9284 12.72 20.09 32.81 46.00 -13.19 5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70			MHz		dB	dBu∨	dBuV	dB	Detecto
3 0.9284 18.40 20.09 38.49 56.00 -17.51 4 0.9284 12.72 20.09 32.81 46.00 -13.19 5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	1		0.4965	26.37	20.08	46.45	56.06	-9.61	QP
4 0.9284 12.72 20.09 32.81 46.00 -13.19 5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	2	*	0.4965	21.55	20.08	41.63	46.06	-4.43	AVG
5 1.4729 19.59 20.09 39.68 56.00 -16.32 6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	3		0.9284	18.40	20.09	38.49	56.00	-17.51	QP
6 1.4729 12.70 20.09 32.79 46.00 -13.21 7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	4		0.9284	12.72	20.09	32.81	46.00	-13.19	AVG
7 2.7285 23.01 20.11 43.12 56.00 -12.88 8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	5		1.4729	19.59	20.09	39.68	56.00	-16.32	QP
8 2.7285 13.55 20.11 33.66 46.00 -12.34 9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	6		1.4729	12.70	20.09	32.79	46.00	-13.21	AVG
9 7.0620 17.63 20.16 37.79 60.00 -22.21 10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	7		2.7285	23.01	20.11	43.12	56.00	-12.88	QP
10 7.0620 7.57 20.16 27.73 50.00 -22.27 11 13.6005 22.03 20.27 42.30 60.00 -17.70	8		2.7285	13.55	20.11	33.66	46.00	-12.34	AVG
11 13.6005 22.03 20.27 42.30 60.00 -17.70	9		7.0620	17.63	20.16	37.79	60.00	-22.21	QP
	10		7.0620	7.57	20.16	27.73	50.00	-22.27	AVG
12 13 6005 9 03 20 27 29 30 50 00 20 70	11		13.6005	22.03	20.27	42.30	60.00	-17.70	QP
12 13.0003 9.03 20.21 29.30 30.00 -20.70	12		13.6005	9.03	20.27	29.30	50.00	-20.70	AVG



Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Phase :	TELE
Test Mode:	Mode 1	Remark:	N/A



Remark:

- All readings are Quasi-Peak and Average values.
 Factor = Insertion Loss + Cable Loss.
 Measurement=Reading Level+ Correct Factor

- 4. Over= Measurement-Limit

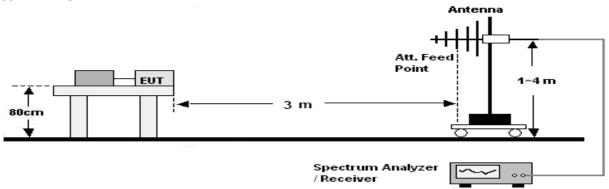
T. OVCI.	- Mcasa	CITICITE LITTIE			1 1			- /
No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz		dB	dBu∨	dBuV	dB	Detector
1		0.1635	51.91	19.82	71.73	83.28	-11.55	QP
2		0.1635	40.57	19.82	60.39	73.28	-12.89	AVG
3		0.4920	46.01	19.97	65.98	74.13	-8.15	QP
4	*	0.4920	39.94	19.97	59.91	64.13	-4.22	AVG
5		1.0859	44.86	20.08	64.94	74.00	-9.06	QP
6		1.0859	29.11	20.08	49.19	64.00	-14.81	AVG
7		2.4224	37.62	20.01	57.63	74.00	-16.37	QP
8		2.4224	25.73	20.01	45.74	64.00	-18.26	AVG
9		5.6220	38.11	20.16	58.27	74.00	-15.73	QP
10		5.6220	25.57	20.16	45.73	64.00	-18.27	AVG
11		11.8905	36.40	20.25	56.65	74.00	-17.35	QP
12		11.8905	27.20	20.25	47.45	64.00	-16.55	AVG



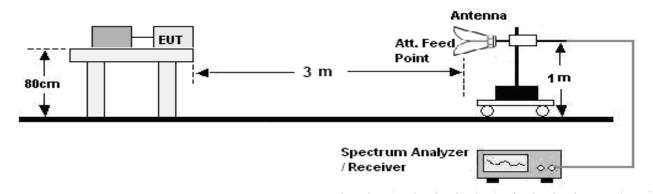
7. Radiated Emissions Test

7.1 Block Diagram Of Test Setup

30MHz ~ 1GHz:



Above 1GHz:



7.2 Limits

Limits for radiated disturbance of Class B MME

Frequency (MHz)	Quasi-peak limits	at 3m Db(Mv/m)	
30-230	4	0	
230-1000	4	7	
Fraguency (CU=)	limit above 1G at 3m Db(Mv/m)		
Frequency (GHz)	Average	peak	
1-3	50	70	
3-6	54	74	

Note: The lower limit shall apply at the transition frequencies.

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7.3 Test Procedure

30MHz ~ 1GHz:

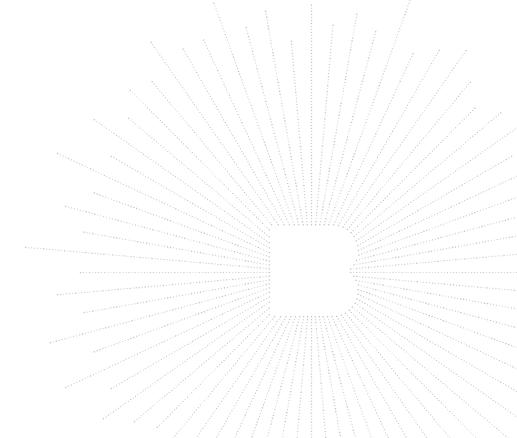
- a. The Product was placed on the nonconductive turntable 0.8 above the ground in a semi anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 120 kHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied between 1~4 m in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its QP value: vary the antenna's height and rotate the turntable from 0 to 360 degrees to find the height and degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to QP Detector and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz:

- a. The Product was placed on the non-conductive turntable 0.8 m above the ground in a full anechoic chamber.
- b. Set the spectrum analyzer/receiver in Peak detector, Max Hold mode, and 1MHz RBW. Record the maximum field strength of all the pre-scan process in the full band when the antenna is varied in both horizontal and vertical, and the turntable is rotated from 0 to 360 degrees.
- c. For each frequency whose maximum record was higher or close to limit, measure its AV value: rotate the turntable from 0 to 360 degrees to find the degree where Product radiated the maximum emission, then set the test frequency analyzer/receiver to AV value and specified bandwidth with Maximum Hold Mode, and record the maximum value.

Above 1GHz

The amplitude of spurious emissions which are attenuated by more than 20Db below the permissible value has no need to be reported.

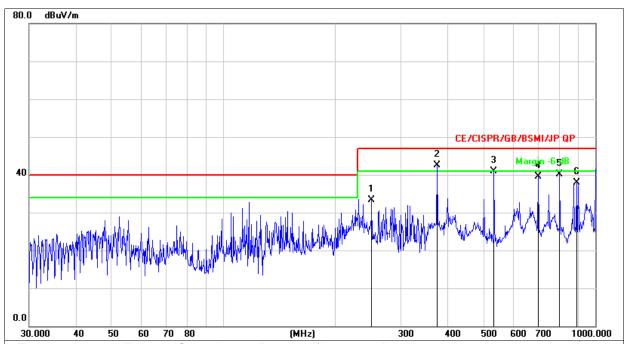


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7.4 Test Results

Temperature:	26℃	Relative Humidity:	54%	
Pressure:	101KPa	Polarization :	Horizontal	
Test Mode:	Mode 1	Remark:	N/A	

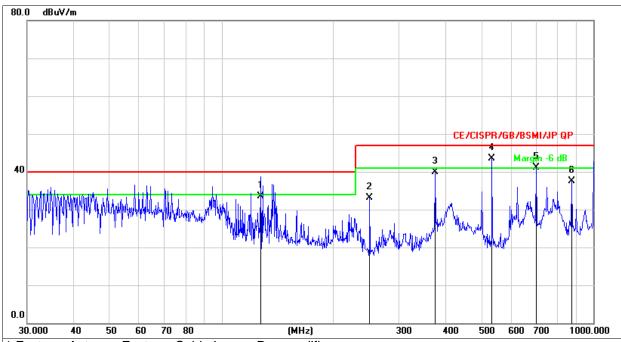


- 1.Factor = Antenna Factor + Cable Loss Pre-amplifier.
- 2. Measurement=Reading Level+ Correct Factor
- 3. Over=Measurement-Limit

1					*				
	No.	Mł	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
-			MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
-	1		250.3012	47.67	-14.28	33.39	47.00	-13.61	QP
-	2	*	375.9385	53.57	-11.15	42.42	47.00	-4.58	QP
-	3		533.8321	50.65	-9.81	40.84	47.00	-6.16	QP
	4		701.7610	45.23	-5.68	39.55	47.00	-7.45	QP
	5		801.7863	44.55	-4.38	40.17	47.00	-6.83	QP
-	6		890.7278	41.20	-3.28	37.92	47.00	-9.08	QP
1 -									-



Temperature:	26℃	Relative Humidity:	54%
Pressure:	101KPa	Polarization :	Vertical
Test Mode:	Mode 1	Remark:	N/A



- 1.Factor = Antenna Factor + Cable Loss Pre-amplifier.
- 2. Measurement=Reading Level+ Correct Factor
- 3. Over=Measurement-Limit

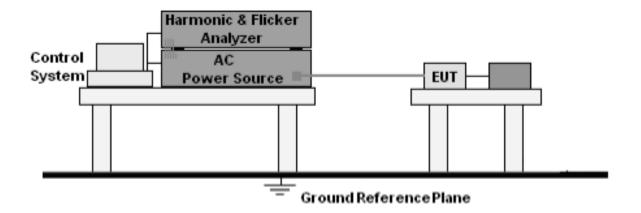
No.	Mk	c. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over	
		MHz	dBuV	dB	dBuV/m	dB/m	dB	Detector
1		127.4845	51.31	-17.85	33.46	40.00	-6.54	QP
2		250.3011	47.42	-14.28	33.14	47.00	-13.86	QP
3		375.9384	51.08	-11.15	39.93	47.00	-7.07	QP
4	*	533.8320	53.29	-9.81	43.48	47.00	-3.52	QP
5	İ	701.7609	46.83	-5.68	41.15	47.00	-5.85	QP
6		875.2469	41.00	-3.55	37.45	47.00	-9.55	QP





8. Harmonic Current Emission(H)

8.1 Block Diagram Of Test Setup



8.2 Limit

EN IEC 61000-3-2:2019+A1:2021

8.3 Test Procedure

- a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the maximum harmonic components under normal operating conditions for each successive harmonic component in turn.
- b. The correspondent test program of test instrument to measure the current harmonics emanated from Product was chosen. The measure time shall be not less than the time necessary for the Product to be exercised.

8.4 Test Results

The EUT is powered by the DC only, the test item is not applicable.

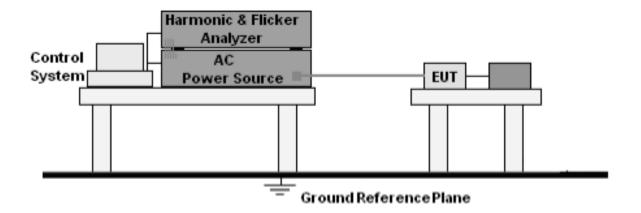
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9. Voltage Fluctuations & Flicker(F)

9.1 Block Diagram Of Test Setup



9.2 Limit

EN 61000-3-3:2013+A2:2021 Clause 5

9.3 Test Procedure

a. The Product was placed on the top of a non-conductive table above the ground and operated to produce the most unfavorable sequence of voltage changes under normal operating conditions.

b. During the flick test, the measure time shall include that part of whole operation cycle in which the Product produce the most unfavorable sequence of voltage changes. The observation period for short-term flicker indicator is 10 minutes and the observation period for long-term flicker indicator is 2 hours.

9.4 Test Results

The EUT is powered by the DC only, the test item is not applicable.

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10. Immunity Test Of General The Performance Criteria

According To EN 301489 -3standard, The General Performance Criteria As Following:

Criteria	During the test	After the test
Α	Operate as intended No loss of function No unintentional responses	Operate as intended No loss of function No degradation of performance No loss of stored data or user programmable functions
В	May show loss of function No unintentional responses	Operate as intended Lost function(s) shall be self-recoverable No degradation of performance No loss of stored data or user programmable functions

According To EN 301489 -17standard, The General Performance Criteria As Following:

Criteria	During test	After test (i.e. as a result of the application of the test)
А	Shall operate as intended. (see note). Shall be no loss of function. Shall be no unintentional transmissions.	Shall operate as intended. Shall be no degradation of performance. Shall be no loss of function. Shall be no loss of critical stored data.
В	May be loss of function.	Functions shall be self-recoverable. Shall operate as intended after recovering. Shall be no loss of critical stored data.
С	May be loss of function.	Functions shall be recoverable by the operator. Shall operate as intended after recovering. Shall be no loss of critical stored data.

NOTE: Operate as intended during the test allows a level of degradation in accordance with Minimum performance level.

Minimum performance level:

For equipment that supports a PER or FER, the minimum performance level shall be a PER or FER less than or equal to 10 %.

For equipment that does not support a PER or a FER, the minimum performance level shall be no loss of the wireless transmission function needed for the intended use of the equipment.

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PERFORMANCE FOR TT

The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration, for which performance criteria C shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR TR

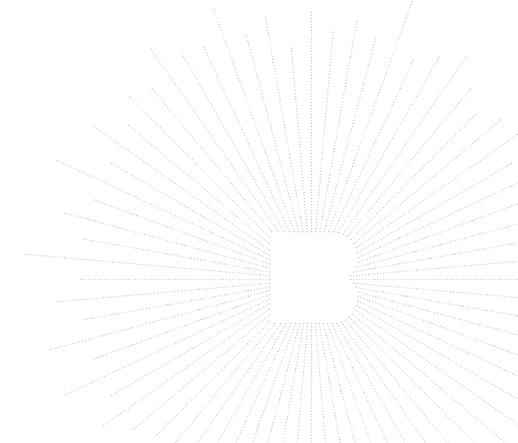
The performance criteria B shall apply, except for voltage dips of 100 ms and voltage interruptions of 5 000 ms duration for which performance criteria C shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CT

The performance criteria A shall apply. Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an Acknowledgement (ACK) or Not Acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

PERFORMANCE FOR CR

The performance criteria A shall apply. Where the EUT is a transceiver, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.



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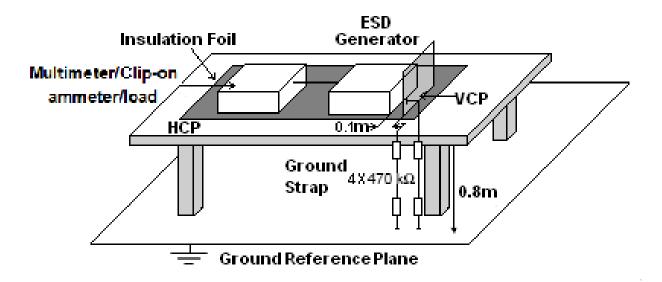
11. Electrostatic Discharge (ESD)

11.1 Test Specification

Test Port : Enclosure port
Discharge Impedance : 330 ohm / 150 pF
Discharge Mode : Single Discharge

Discharge Period : one second between each discharge

11.2 Block Diagram Of Test Setup



11.3 Test Procedure

- a. Electrostatic discharges were applied only to those points and surfaces of the Product that are accessible to users during normal operation.
- b. The test was performed with at least ten single discharges on the pre-selected points in the most sensitive polarity.
- c. The time interval between two successive single discharges was at least 1 second.
- d. The ESD generator was held perpendicularly to the surface to which the discharge was applied and the return cable was at least 0.2 meters from the Product.
- e. Contact discharges were applied to the non-insulating coating, with the pointed tip of the generator penetrating the coating and contacting the conducting substrate.
- f. Air discharges were applied with the round discharge tip of the discharge electrode approaching the Product as fast as possible (without causing mechanical damage) to touch the Product. After each discharge, the ESD generator was removed from the Product and re-triggered for a new single discharge. The test was repeated until all discharges were complete.

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11.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%
Pressure:	101KPa	Test Mode:	Mode 1

Mode		Air Discharge Contact Discharge (Test result) (Test result)							Donform									
Test level (kV)	2	2	4	4	8	3	1	5	2	2	4	1	6	6	8	3	Perform Criteria	Judgment
Test Location	+	1	+	-	+	-	+	-	+	ı	+	ı	+	-	+	-		
HCP									Α	Α	Α	Α					TT,TR	PASS
VCP									Α	Α	Α	Α					TT,TR	PASS
enclosure	Α	Α	Α	Α	Α	Α			Α	Α	Α	Α					TT,TR	PASS
Keys	Α	Α	Α	Α	Α	Α											TT,TR	PASS
Port	Α	Α	Α	Α	Α	Α			Α	Α	Α	Α					TT,TR	PASS
Metal									В	В	В	В					TT,TR	PASS

Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) Test condition: Direct / Indirect (HCP/VCP) discharges: Minimum 50 times (Positive/Negative) at each point. Air discharges: Minimum 10 times (Positive/Negative) at each point.
- 3) N/A denotes test is not applicable in this test report
- 4) B* Contact ±4KV to play any metal port, screen display interruption, can be automatically restored.

,TC

3C



12. Continuous RF Electromagnetic Field Disturbances(RS)

12.1 Test Specification

Test Port : Enclosure port

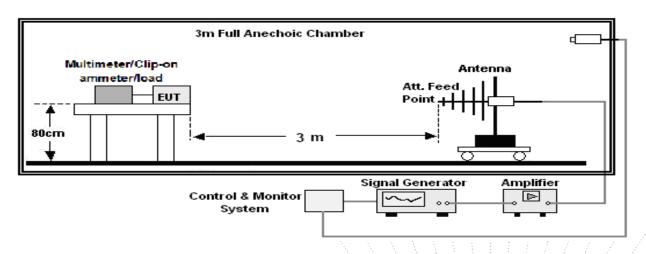
Step Size : 1%

Modulation: 1kHz, 80% AMDwell Time: 1 second

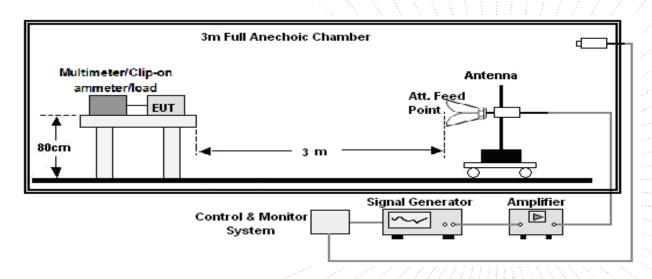
Polarization : Horizontal & Vertical

12.2 Block Diagram Of Test Setup

Below 1GHz:



Above 1GHz:



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12.3 Test Procedure

- a. The testing was performed in a fully-anechoic chamber. The transmit antenna was located at a distance of 3 meters from the Product.
- b. The frequency range is swept from 80MHz to 6000MHz, with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1%.
- c. The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised and to be able to respond, but should not exceed 5 s at each of the frequencies during the scan.
- d. The test was performed with the Product exposed to both vertically and horizontally polarized fields on each of the four sides.
- e. For Broadcast reception function: Group 2 not apply in this test.

12.4 Test Results

Temperature:	26 ℃	Relative Humidity:	54%	
Pressure:	101KPa	Test Mode:	Mode 1	

Frequency Range (MHz)	RF Field Position	R.F. Field Strength	Azimuth	Perform Criteria	Test Result	Judgment
			Front			
80~6000	H/V	3 V/m (rms) AM Modulated	Rear	CT,CR	A	PASS
00~0000	117 V	1000Hz, 80%	Left	01,010		1 700
			Right			

Note:

- 1) P/N denotes the Positive/Negative polarity of the output voltage.
- 2) N/A denotes test is not applicable in this test report.
- 3) There was no change operated with initial operating during the test.
- 4) There was not any unintentional transmission in standby mode

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13. Electrical Fast Transients/Burst (EFT)

13.1 Test Specification

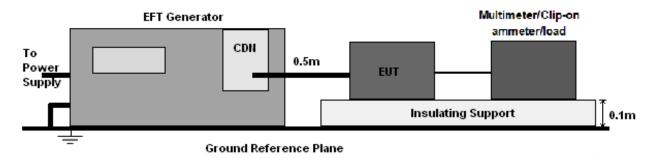
Test Port : input AC / DC power port

Impulse Frequency: 5 kHzImpulse Wave-shape: 5/50 nsBurst Duration: 15 msBurst Period: 300 ms

Test Duration : 2 minutes per polarity

13.2 Block Diagram Of EUT Test Setup

For input AC / DC power port:



13.3 Test Procedure

a. The Product and support units were located on a non-conductive table above ground reference plane.

b. A 0.5m-long power cord was attached to Product during the test.

13.4 Test Results

The EUT is powered by the DC only, the test item is not applicable.

12 CO.,LT/



14. Surges Immunity Test

14.1 Test Specification

Test Port : input AC / DC power port

Wave-Shape : Open Circuit Voltage - 1.2 / 50 us

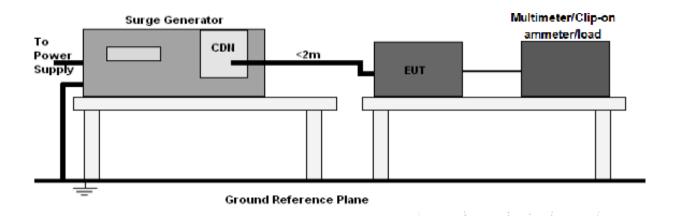
Short Circuit Current - 8 / 20 us

Pulse Repetition Rate : 1 pulse / min.

Phase Angle : $0^{\circ} / 90^{\circ} / 180^{\circ} / 270^{\circ}$

Test Events : 5 pulses (positive & negative) for each polarity

14.2 Block Diagram Of EUT Test Setup



14.3 Test Procedure

a. The surge is to be applied to the Product power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. b. The power cord between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter). Interconnection line between the Product and the coupling/decoupling networks shall be 2 meters in length (or shorter).

14.4 Test Result

The EUT is powered by the DC only, the test item is not applicable.



15. Continuous Induced RF Disturbances (CS)

15.1 Test Specification

Test Port : input AC / DC power port

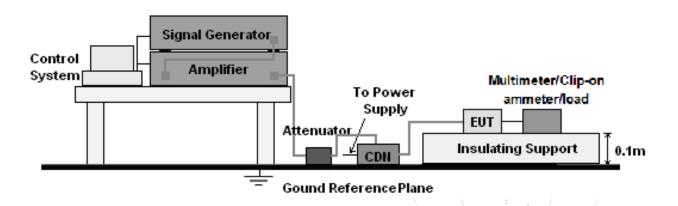
Step Size : 1%

Modulation : 1kHz, 80% AM

Dwell Time : 1 second

15.2 Block Diagram Of EUT Test Setup

For input AC / DC power port:



15.3 Test Procedure

For input AC/ DC power port:

- a. The Product and support units were located at a ground reference plane with the interposition of a 0.1 m thickness insulating support and the CDN was located on GRP directly.
- b. The frequency range is swept from 150 kHz to 10MHz, 10MHz to 30MHz, 30MHz to 80MHz with the signal 80% amplitude modulated with a 1 kHz sine wave, and the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the Product to be able to respond.

15.4 Test Result

The EUT is powered by the DC only, the test item is not applicable.



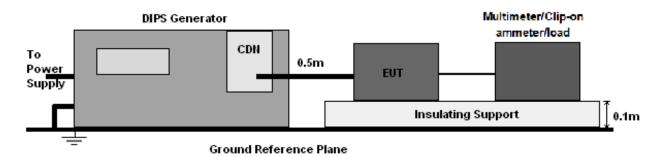
16. Voltage Dips And Interruptions (DIPS)

16.1 Test Specification

Test Port : input AC power port

Phase Angle : 0°, 180° Test cycle : 3 times

16.2 Block Diagram Of EUT Test Setup



16.3 Test Procedure

- a. The Product and support units were located on a non-conductive table above ground floor.
- b. Set the parameter of tests and then perform the test software of test simulator.
- c. Conditions changes to occur at 0 degree crossover point of the voltage waveform.

16.4 Test Result

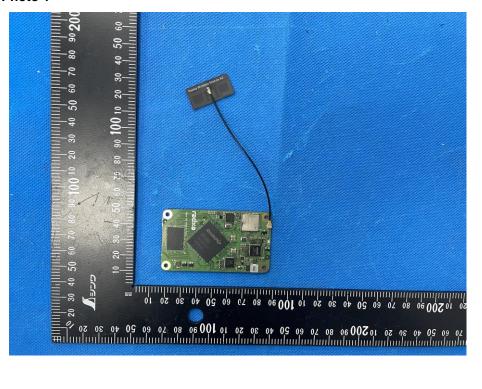
The EUT is powered by the DC only, the test item is not applicable.

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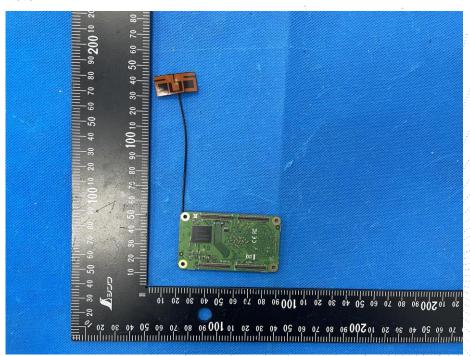


17. EUT Photographs

EUT Photo 1



EUT Photo 2



NOTE: Appendix-Photographs Of EUT Constructional Details.

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18. EUT Test Setup Photographs

Conducted emissions



TELE



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Radiated emissions



ESD

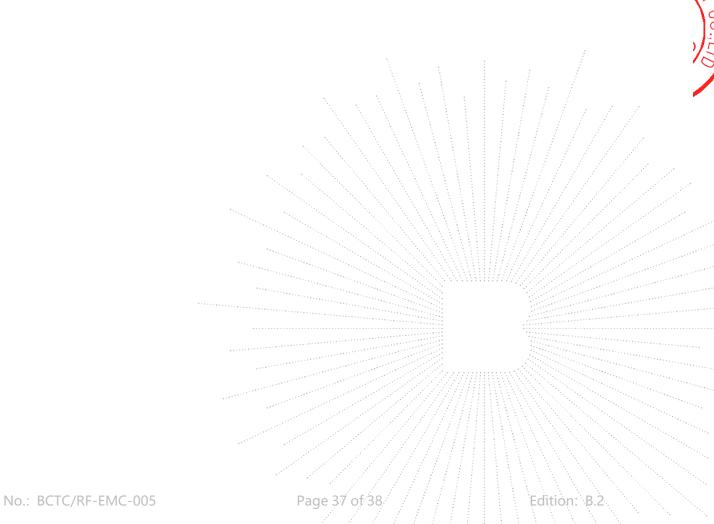


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RS







STATEMENT

- 1. The equipment lists are traceable to the national reference standards.
- 2. The test report can not be partially copied unless prior written approval is issued from our lab.
- 3. The test report is invalid without the "special seal for inspection and testing".
- 4. The test report is invalid without the signature of the approver.
- 5. The test process and test result is only related to the Unit Under Test.
- 6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.
- 7. The quality system of our laboratory is in accordance with ISO/IEC17025.
- 8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

Address:

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